#### Chapter 17

#### Failure-Time Regression Analysis

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### Chapter 17 Failure-Time Regression Analysis

Topics discussed in this chapter are:

- Applications of failure-time regression.
- Graphical methods for displaying censored regression data.
- Simple regression models to relate life to explanatory variables.
- The use of likelihood methods for censored regression data.
- The importance of model diagnostics.
- Extensions to nonstandard multiple regression models.

### Chapter 17

### Failure-Time Regression Analysis

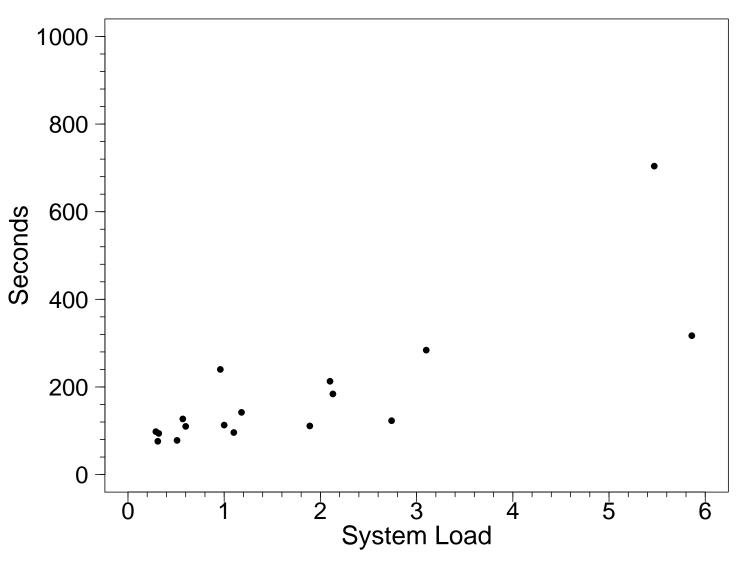
Segment 1

Introduction to Failure-Time Regression

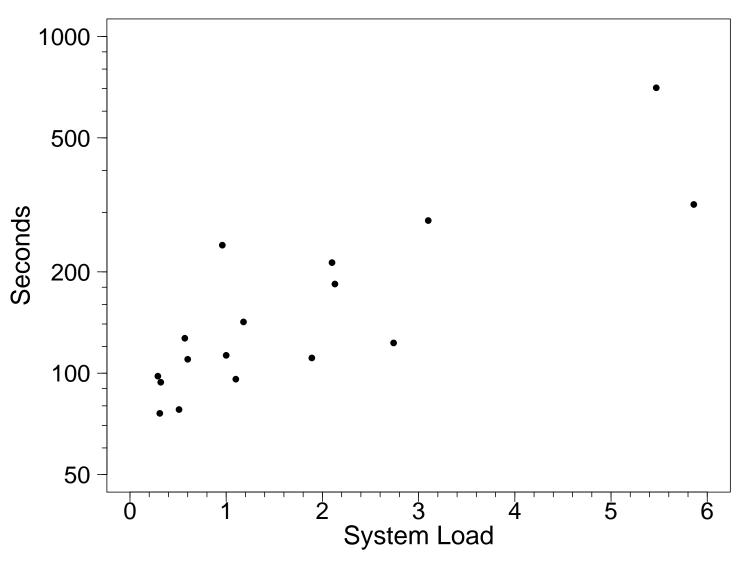
### Computer Program Execution Time Versus System Load

- Time to complete a computationally-intensive task.
- Information from the Unix uptime command.
- Predictions needed for scheduling subsequent steps in a multi-step computational process.

## Scatter Plot of Computer Program Execution Time Versus System Load Linear-Linear



# Scatter Plot of Computer Program Execution Time Versus System Load Log-Linear



#### **Explanatory Variables for Failure Times**

Useful explanatory variables explain/predict why some units fail quickly and some units survive for a long time.

- Continuous variables like stress, temperature, voltage, and pressure.
- Discrete variables like the number of hardening treatments or the number of simultaneous users of a system.
- Categorical variables like manufacturer, design, operator, and location.

Regression model relates failure time distribution to explanatory variables  $x = (x_1, \dots, x_k)$ :

$$Pr(T \le t) = F(t) = F(t; x).$$

#### Failure-Time Regression Analysis

 Material in this chapter is an extension of statistical regression analysis with normal distributed data and

$$mean = \beta_0 + \beta_1 x_1 + \dots + \beta_k x_k$$

where the  $x_i$  are explanatory variables.

- The ideas presented here are more general:
  - ▶ Data not necessarily from a normal distribution.
  - ▶ Data may be censored.
  - ► Nonstandard regression models that relate life to explanatory variables.
- Presentation motivated by practical problems in reliability analysis.

### Lognormal Distribution Simple Regression Model with Constant Shape Parameter $\sigma$

• The lognormal simple regression model is

$$\Pr(T \le t) = F(t; \mu, \sigma) = F(t; \beta_0, \beta_1, \sigma) = \Phi_{\text{norm}} \left[ \frac{\log(t) - \mu}{\sigma} \right]$$

where  $\mu = \mu(x) = \beta_0 + \beta_1 x$  and  $\sigma$  does not depend on x.

• The failure-time log quantile function

$$\log[t_p(x)] = \mu(x) + \Phi_{\mathsf{norm}}^{-1}(p) \,\sigma$$

is linear in x.

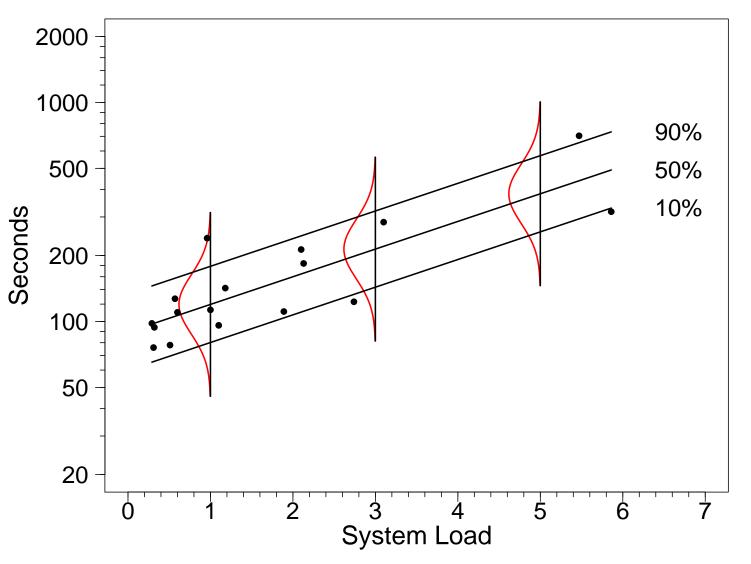
Notice that

$$AF = \frac{t_p(x)}{t_p(0)} = \exp(\beta_1 x)$$

does not depend on p, implying that changes in x only scale time.

### Computer Program Execution Time Versus System Load Log-Linear Lognormal Regression Model

$$\log[\hat{t}_p(x)] = \hat{\mu}(x) + \Phi_{\mathbf{norm}}^{-1}(p)\hat{\sigma}$$



### Likelihood for Lognormal Distribution Simple Regression Model with Right-Censored Data

The likelihood for n independent observations has the form

$$L(\beta_0, \beta_1, \sigma) = \prod_{i=1}^n L_i(\beta_0, \beta_1, \sigma; \mathsf{data}_i)$$

$$= \prod_{i=1}^n \left\{ \frac{1}{\sigma t_i} \phi_{\mathsf{norm}} \left[ \frac{\mathsf{log}(t_i) - \mu_i}{\sigma} \right] \right\}^{\delta_i} \left\{ 1 - \Phi_{\mathsf{norm}} \left[ \frac{\mathsf{log}(t_i) - \mu_i}{\sigma} \right] \right\}^{1 - \delta_i}$$

where data<sub>i</sub> =  $(x_i, t_i, \delta_i)$ ,  $\mu_i = \beta_0 + \beta_1 x_i$ ,

$$\delta_i = \left\{ \begin{array}{ll} 1 & \text{exact observation} \\ 0 & \text{right-censored observation} \end{array} \right.,$$

 $\phi_{\text{norm}}(z)$  is the standardized normal pdf, and  $\Phi_{\text{norm}}(z)$  is the corresponding normal cdf.

The parameters are  $\theta = (\beta_0, \beta_1, \sigma)$ .

#### **Estimated Parameter Variance-Covariance Matrix**

Local (observed information) estimate

$$\widehat{\Sigma}_{\widehat{\theta}} = \begin{bmatrix} \widehat{\mathsf{Var}}(\widehat{\beta}_0) & \widehat{\mathsf{Cov}}(\widehat{\beta}_0, \widehat{\beta}_1) & \widehat{\mathsf{Cov}}(\widehat{\beta}_0, \widehat{\sigma}) \\ \widehat{\mathsf{Cov}}(\widehat{\beta}_1, \widehat{\beta}_0) & \widehat{\mathsf{Var}}(\widehat{\beta}_1) & \widehat{\mathsf{Cov}}(\widehat{\beta}_1, \widehat{\sigma}) \\ \widehat{\mathsf{Cov}}(\widehat{\sigma}, \widehat{\beta}_0) & \widehat{\mathsf{Cov}}(\widehat{\sigma}, \widehat{\beta}_1) & \widehat{\mathsf{Var}}(\widehat{\sigma}) \end{bmatrix}$$

$$= \begin{bmatrix} -\frac{\partial^{2}\mathcal{L}(\beta_{0},\beta_{1},\sigma)}{\partial\beta_{0}^{2}} & -\frac{\partial^{2}\mathcal{L}(\beta_{0},\beta_{1},\sigma)}{\partial\beta_{0}\partial\beta_{1}} & -\frac{\partial^{2}\mathcal{L}(\beta_{0},\beta_{1},\sigma)}{\partial\beta_{0}\partial\sigma} \\ -\frac{\partial^{2}\mathcal{L}(\beta_{0},\beta_{1},\sigma)}{\partial\beta_{1}\partial\beta_{0}} & -\frac{\partial^{2}\mathcal{L}(\beta_{0},\beta_{1},\sigma)}{\partial\beta_{1}^{2}} & -\frac{\partial^{2}\mathcal{L}(\beta_{0},\beta_{1},\sigma)}{\partial\beta_{1}\partial\sigma} \\ -\frac{\partial^{2}\mathcal{L}(\beta_{0},\beta_{1},\sigma)}{\partial\sigma\partial\beta_{0}} & -\frac{\partial^{2}\mathcal{L}(\beta_{0},\beta_{1},\sigma)}{\partial\sigma\partial\beta_{1}} & -\frac{\partial^{2}\mathcal{L}(\beta_{0},\beta_{1},\sigma)}{\partial\sigma^{2}} \end{bmatrix}^{-1}$$

Partial derivatives are evaluated at  $\hat{\beta}_0, \hat{\beta}_1, \hat{\sigma}$ .

### Standard Errors and Confidence Intervals for Parameters

• Lognormal ML estimates for the computer time experiment were  $\hat{\theta} = (\hat{\beta}_0, \hat{\beta}_1, \hat{\sigma}) = (4.49, 0.290, 0.312)$  and an estimate of the variance-covariance matrix for  $\hat{\theta}$  is

$$\widehat{\Sigma}_{\widehat{\theta}} = \begin{bmatrix} 0.012 & -0.0037 & 0 \\ -0.0037 & 0.0021 & 0 \\ 0 & 0 & 0.0029 \end{bmatrix}.$$

 Wald confidence interval for the computer execution time regression slope is

$$[\underline{\beta_1}, \ \widehat{\beta_1}] = \widehat{\beta}_1 \pm z_{(0.975)} \operatorname{se}_{\widehat{\beta}_1} = 0.290 \pm 1.96(0.046) = [0.20, \ 0.38]$$
 where  $\operatorname{se}_{\widehat{\beta}_1} = \sqrt{0.0021} = 0.046$ .

### Standard Errors and Confidence Intervals for Quantities at Specific Explanatory Variable Conditions

- Unknown values of  $\mu$  and  $\sigma$  at each level of x.
- $\hat{\mu} = \hat{\beta}_0 + \hat{\beta}_1 x$ ,  $\sigma$  does not depend on x, and

$$\widehat{\Sigma}_{\widehat{\mu},\widehat{\sigma}} = \begin{bmatrix} \widehat{\mathsf{Var}}(\widehat{\mu}) & \widehat{\mathsf{Cov}}(\widehat{\mu},\widehat{\sigma}) \\ \widehat{\mathsf{Cov}}(\widehat{\mu},\widehat{\sigma}) & \widehat{\mathsf{Var}}(\widehat{\sigma}) \end{bmatrix}$$

is obtained from  $\widehat{\text{Var}}(\widehat{\mu}) = \widehat{\text{Var}}(\widehat{\beta}_0) + 2x\widehat{\text{Cov}}(\widehat{\beta}_1, \widehat{\beta}_0) + x^2\widehat{\text{Var}}(\widehat{\beta}_1)$  and  $\widehat{\text{Cov}}(\widehat{\mu}, \widehat{\sigma}) = \widehat{\text{Cov}}(\widehat{\beta}_0, \widehat{\sigma}) + x\widehat{\text{Cov}}(\widehat{\beta}_1, \widehat{\sigma})$ .

- Use the above results with the methods from Chapter 8 to compute Wald confidence intervals for F(t), h(t), and  $t_p$ .
- Could also use likelihood or simulation-based confidence intervals.

#### Chapter 17

### Failure-Time Regression Analysis

Segment 2

Nonconstant Variance in Failure-Time Regression

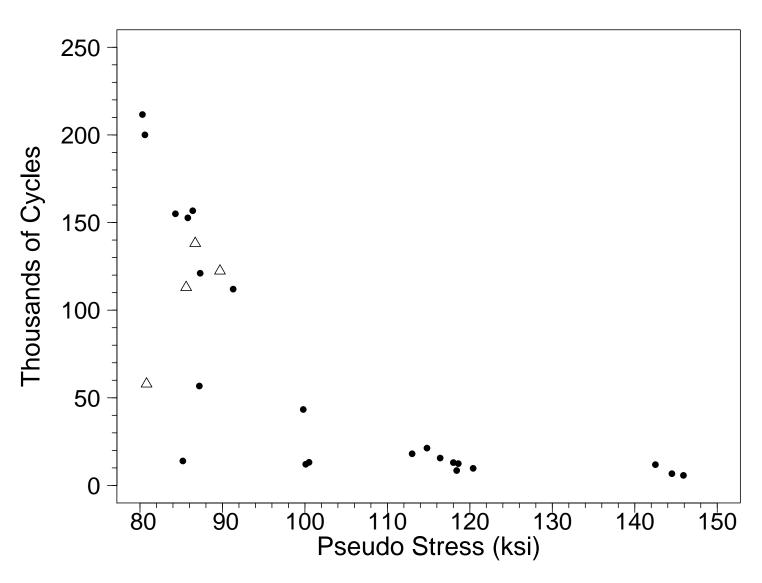
### Nickel-Base Super-Alloy Fatigue Data 26 Observations in Total, 4 Censored

Originally described and analyzed by Nelson (1984) and Nelson (2004).

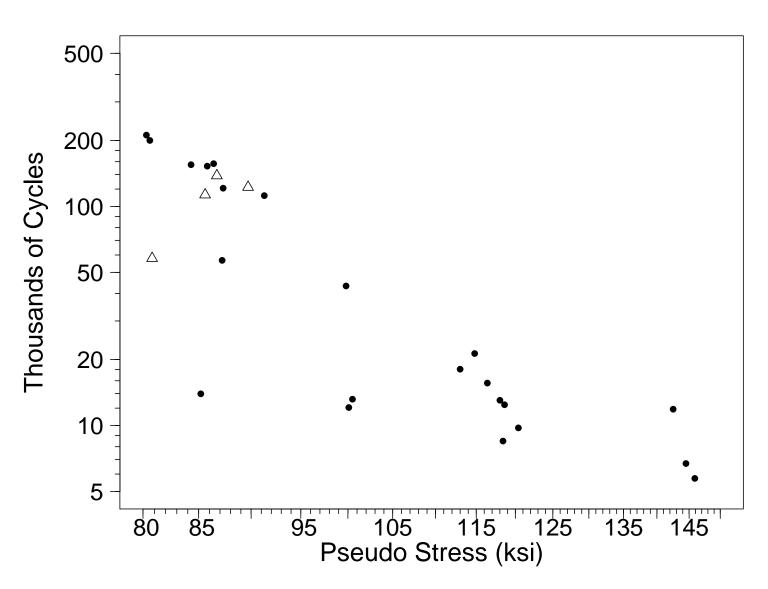
- Thousands of cycles to failure as a function of **pseudo- stress** in ksi.
- Pseudo-stress is Young's modulus multiplied to strain.
- 26 units tested; 4 units did not fail.

**Objective:** Find a regression model to describe the relationship between fatigue life and pseudo-stress (i.e., find an S/N curve).

### Nickel-Base Super-Alloy Fatigue Data Linear-Linear



### Nickel-Base Super-Alloy Fatigue Data Log-Log



### Weibull Distribution Quadratic Regression Model with Constant Shape Parameter $\beta=1/\sigma$

This is a lifetime model with the following characteristics:

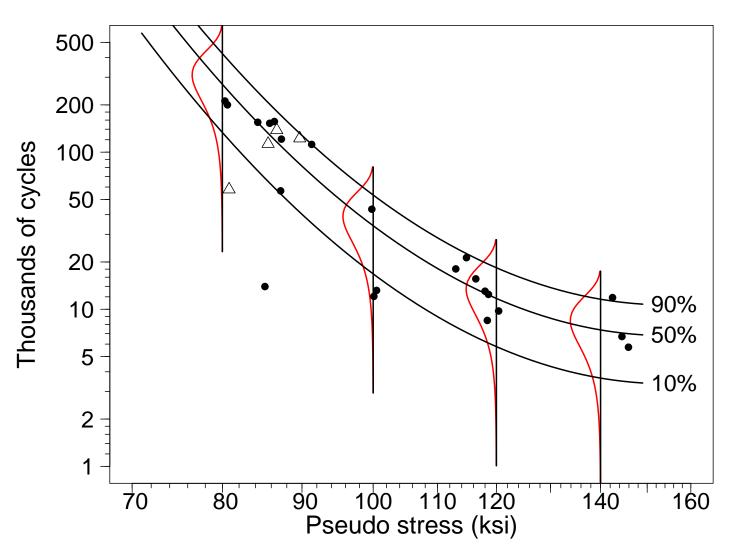
The Weibull quadratic regression model is

$$\Pr[T \le t] = \Phi_{\text{SeV}} \left[ \frac{\log(t) - \mu}{\sigma} \right]$$

where  $\mu = \mu(x) = \beta_0 + \beta_1 x + \beta_2 x^2$  and  $\sigma$  does not depend on x.

•  $x = \log(\text{Pseudo-stress})$ .

# Log-Quadratic Weibull Regression Model with Constant ( $\beta=1/\sigma$ ) Fit to the Super-Alloy Data $\log[\widehat{t}_p(x)]=\widehat{\mu}(x)+\Phi_{\rm sev}^{-1}(p)\widehat{\sigma}$ , $x=\log({\rm pseudo-stress})$ $\widehat{\mu}=\widehat{\beta}_0+\widehat{\beta}_1x+\widehat{\beta}_2x^2$



### Likelihood for Weibull Distribution Quadratic Regression Model with Right-Censored Data

The likelihood for n independent observations is

$$\begin{split} L(\beta_0, \beta_1, \beta_2, \sigma) &= \prod_{i=1}^n L_i(\beta_0, \beta_1, \beta_2, \sigma; \mathsf{data}_i) \\ &= \prod_{i=1}^n \left\{ \frac{1}{\sigma t_i} \phi_{\mathsf{Sev}} \bigg[ \frac{\mathsf{log}(t_i) - \mu_i}{\sigma} \bigg] \right\}^{\delta_i} \left\{ 1 - \Phi_{\mathsf{Sev}} \bigg[ \frac{\mathsf{log}(t_i) - \mu_i}{\sigma} \bigg] \right\}^{1 - \delta_i}. \end{split}$$

where  $\mu_i = \beta_0 + \beta_1 x_i + \beta_2 x_i^2$ ,

$$\delta_i = \left\{ \begin{array}{ll} 1 & \text{exact observation} \\ 0 & \text{right-censored observation} \end{array} \right.$$

The parameters are  $\theta = (\beta_0, \beta_1, \beta_2, \sigma)$ .

### Weibull Distribution Quadratic Regression Model with Nonconstant $\beta=1/\sigma$

The Weibull quadratic regression model is

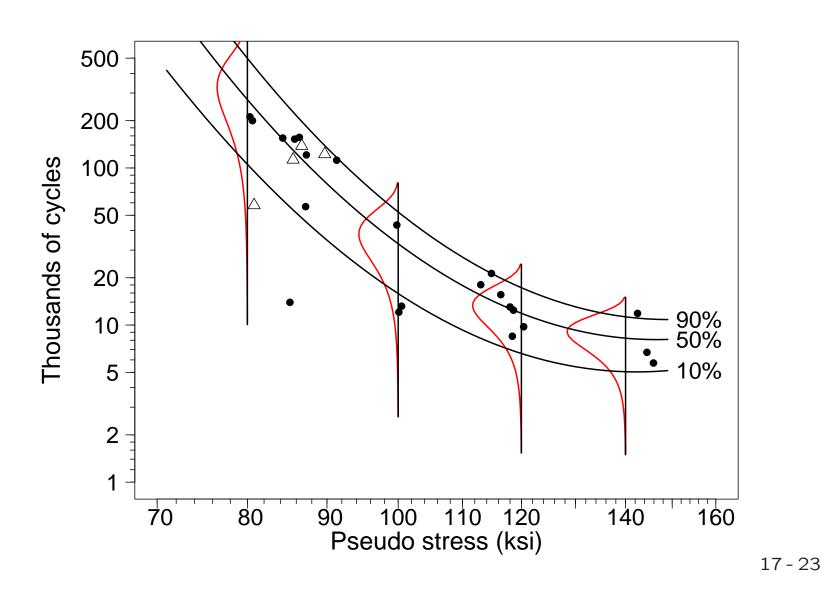
$$\Pr[T \leq t] = \Phi_{\text{SeV}}\{\lceil \log(t) - \mu \rceil/\sigma\},$$
 where  $\mu = \mu(x) = \beta_0^{[\mu]} + \beta_1^{[\mu]}x + \beta_2^{[\mu]}x^2$  and 
$$\log(\sigma) = \log[\sigma(x)] = \beta_0^{[\sigma]} + \beta_1^{[\sigma]}x.$$

The failure-time log quantile function is

$$\log[t_p(x)] = \mu(x) + \Phi_{\text{SeV}}^{-1}(p) \, \sigma(x)$$

which is **not** quadratic in x.

# Log-Quadratic Weibull Regression Model with Nonconstant $\beta=1/\sigma$ Fit to the Super-Alloy Data $\log[\widehat{t}_p(x)]=\widehat{\mu}(x)+\Phi_{\text{sev}}^{-1}(p)\widehat{\sigma}(x)$ , $x=\log(\text{pseudo-stress})$ $\widehat{\mu}=\widehat{\beta}_0+\widehat{\beta}_1x+\widehat{\beta}_2x^2$ , $\log(\widehat{\sigma})=\widehat{\beta}_0^{[\sigma]}+\widehat{\beta}_1^{[\sigma]}x$



# Likelihood for Weibull Distribution Quadratic Regression Model with Nonconstant $\beta=1/\sigma$ and Right-Censored Data

The likelihood for n independent observations has the form

$$\begin{split} &L(\beta_0^{[\mu]},\beta_1^{[\mu]},\beta_2^{[\mu]},\beta_0^{[\sigma]},\beta_1^{[\sigma]})\\ &=\prod_{i=1}^n L_i(\beta_0^{[\mu]},\beta_1^{[\mu]},\beta_2^{[\mu]},\beta_0^{[\sigma]},\beta_1^{[\sigma]}; \mathrm{data}_i)\\ &=\prod_{i=1}^n \left\{\frac{1}{\sigma_i t_i} \phi_{\mathrm{Sev}} \left[\frac{\log(t_i) - \mu_i}{\sigma_i}\right]\right\}^{\delta_i} \left\{1 - \Phi_{\mathrm{Sev}} \left[\frac{\log(t_i) - \mu_i}{\sigma_i}\right]\right\}^{1 - \delta_i}. \end{split}$$
 where  $\mu_i = \beta_0^{[\mu]} + \beta_1^{[\mu]} x_i + \beta_2^{[\mu]} x_i^2 \text{ and } \sigma_i = \exp\left(\beta_0^{[\sigma]} + \beta_1^{[\sigma]} x_i\right). \end{split}$  Parameters are  $\boldsymbol{\theta} = (\beta_0^{[\mu]}, \beta_1^{[\mu]}, \beta_2^{[\mu]}, \beta_0^{[\sigma]}, \beta_1^{[\sigma]}). \end{split}$ 

#### Chapter 17

Failure-Time Regression Analysis

Segment 3

**Empirical Models and Extrapolation** and Checking Model Assumptions

#### **Extrapolation and Empirical Models**

- Empirical models can be useful, providing a smooth curve to describe a population or a process.
- When using an empirical model, it is dangerous to extrapolate outside of the range of one's data.
- There are different kinds of extrapolation
  - ▶ To the upper tail of a distribution.
  - ▶ To the lower tail of a distribution.
  - ▶ In an explanatory variable like stress or temperature.
- Need to get the right curve to extrapolate: look toward physical or other process theory.

#### **Checking Model Assumptions**

- Graphical checks using generalizations of usual diagnostics (including residual analysis)
  - ► Residuals versus fitted values.
  - Probability plot of residuals.
  - ► Residuals versus other potential explanatory variables.
  - ► Fitted values versus actual response.
- Most analytical tests can be suitably generalized, at least approximately, for censored data (especially using likelihood ratio tests).

#### **Definition of Standardized Residuals**

• For location-scale distributions like the normal, logistic, largest extreme value, and smallest extreme value,

$$\widehat{\epsilon}_i = \frac{y_i - \widehat{y}_i}{\widehat{\sigma}}$$

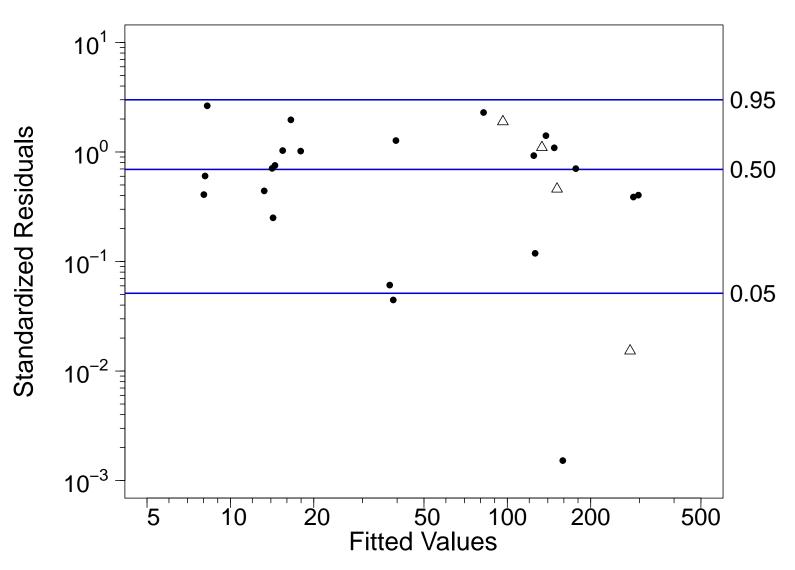
where  $\hat{y}_i$  is an appropriately defined fitted value (e.g.,  $\hat{y}_i = \hat{\mu}_i$ ).

 With models for positive random variables like Weibull, lognormal, and loglogistic, standardized residuals are defined as

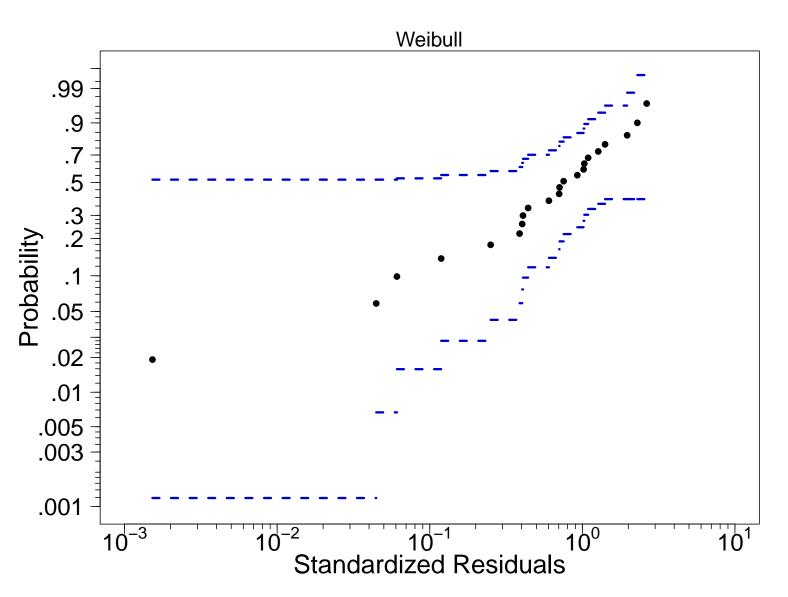
$$\exp(\widehat{\epsilon}_i) = \exp\left[\frac{\log(t_i) - \log(\widehat{t}_i)}{\widehat{\sigma}}\right] = \left(\frac{t_i}{\widehat{t}_i}\right)^{1/\widehat{\sigma}}$$

where  $\hat{t}_i = \exp(\hat{\mu}_i)$  and when  $t_i$  is a censored observation, the corresponding residual is also censored.

## Plot of Standardized Residuals Versus Fitted Values for the Log-Quadratic Weibull Regression Model Fit to the Super Alloy Data on Log-Log Axes



### Probability Plot of the Standardized Residuals from the Log-Quadratic Weibull Regression Model Fit to the Super Alloy Data



### Empirical Regression Models and Sensitivity Analysis Objectives and Strategy

- Describe a class of regression models that can be used to describe the relationship between failure time and explanatory variables. Use data and previous experience to choose a base-line model. Fit the following models to check assumptions:
  - ▶ Separate distribution at each condition.
  - $\blacktriangleright$  Separate distribution at each condition with  $\sigma$  fixed.
  - ► Regression relationship between explanatory variables and distributions at individual conditions.
- Fit the chosen empirical regression models and use diagnostics (e.g., residual analysis) to check their fits.
- Assess uncertainty
  - ► Confidence intervals quantify statistical uncertainty.
  - ► Perturb and otherwise change the model and reanalyze (sensitivity analysis) to assess model uncertainty.

#### Chapter 17

### Failure-Time Regression Analysis

Segment 4

Transformations of a Positive Explanatory Variable

### Transformations of a Positive Explanatory Variable

- In choosing an empirical model, it is often necessary to transform the explanatory variable in order to achieve a better fit to data.
- For example, curvature in a scatter plot of y versus x may suggest that a model quadratic in x will provide a better fit than one that is linear in x. In this case, the response  $t_i$  might be modeled as a function of  $x_i^* = x_i^2$ .
- A formal way of choosing an appropriate transformation is to consider one from the Box-Cox family of transformations.
- A sensitivity analysis should be performed to assess the effect of different transformations on the analysis.

### Examples of Monotone Increasing Power Transformations of a Positive Explanatory Variable

λ	Transformation
-2	$x_i^* = -1/x_i^2$
-1	$x_i^* = -1/x_i$
-0.5	$x_i^* = -1/\sqrt{x_i}$
-0.333	$x_i^* = -1/x_i^{1/3}$
0	$x_i^* \stackrel{\text{def}}{=} \log(x_i)$
0.333	$x_i^* = x_i^{1/3}$
0.5	$x_i^* = \sqrt{x_i}$
1	$x_i^* = x_i$
2	$x_i^* = x_i^2$

#### **Box-Cox Transformation**

 The Box–Cox family of power transformations of a positive explanatory variable is

$$x_i^* = \begin{cases} \frac{x_i^{\lambda} - 1}{\lambda} & \lambda \neq 0\\ \log(x_i) & \lambda = 0 \end{cases}$$

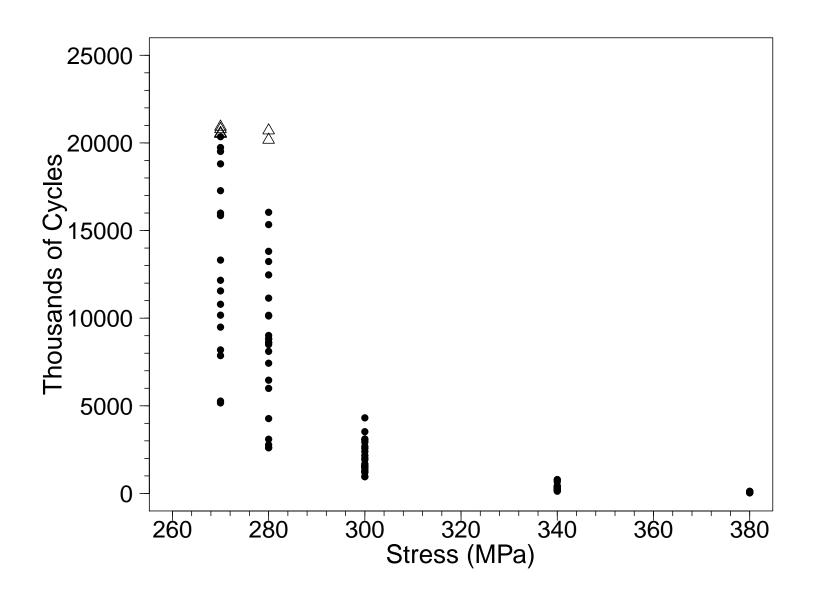
where  $x_i$  is the original, untransformed explanatory variable for observation i and  $\lambda$  is the power transformation parameter.

- The Box–Cox transformation has the following important properties:
  - ▶ The transformed value  $x_i^*$  is an increasing function of  $x_i$ .
  - ▶ For fixed  $x_i$ ,  $x_i^*$  is a continuous function of  $\lambda$  through 0.

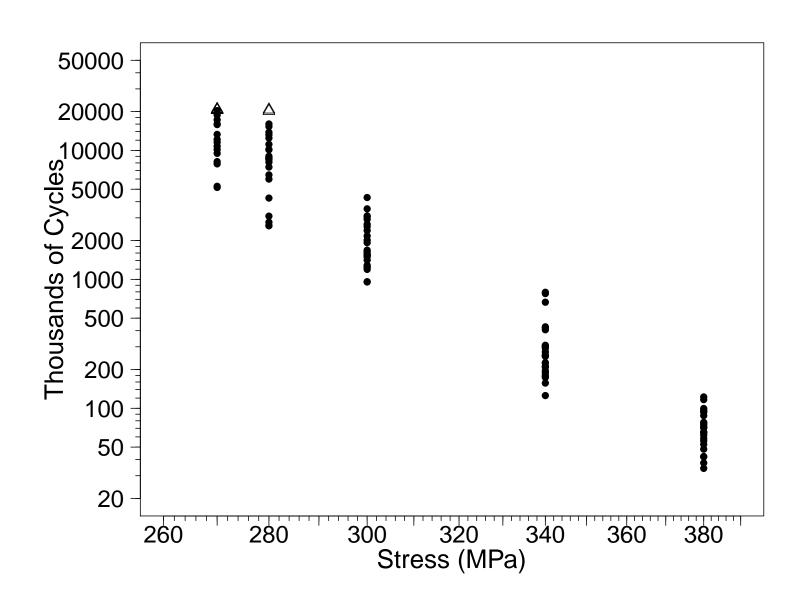
#### Estimation of an S-N Curve for a Laminate Panel Data

- 125 circular-holed notched specimens of a carbon eightharness-satin/epoxy laminate panel were subjected to a cyclic four-point out-of-plane bending.
- Units tested at 270, 280, 300, 340, and 380 MPa.
- Some "runouts" at 270 and 280 MPa (8 and 2, respectively).
- Data are from Shimokawa and Hamaguchi (1987).

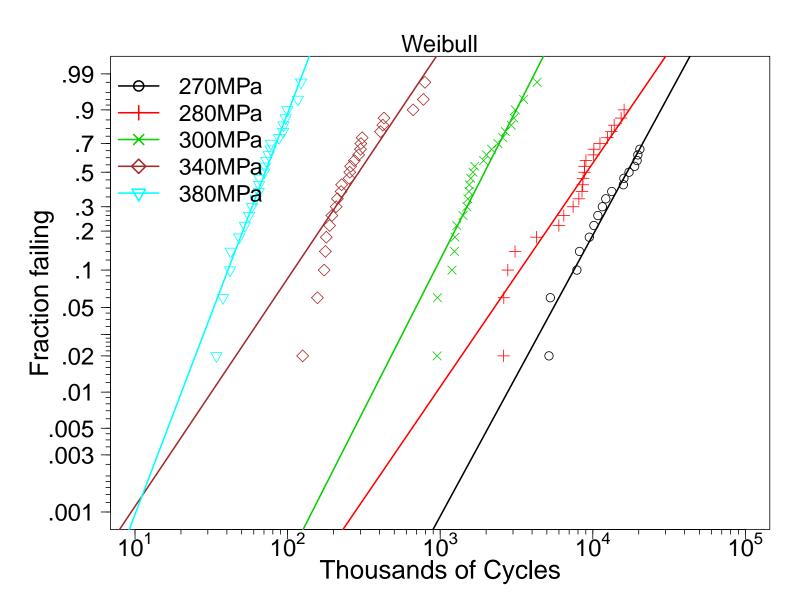
#### Laminate Panel Data Scatter Plot Linear-Linear Axes



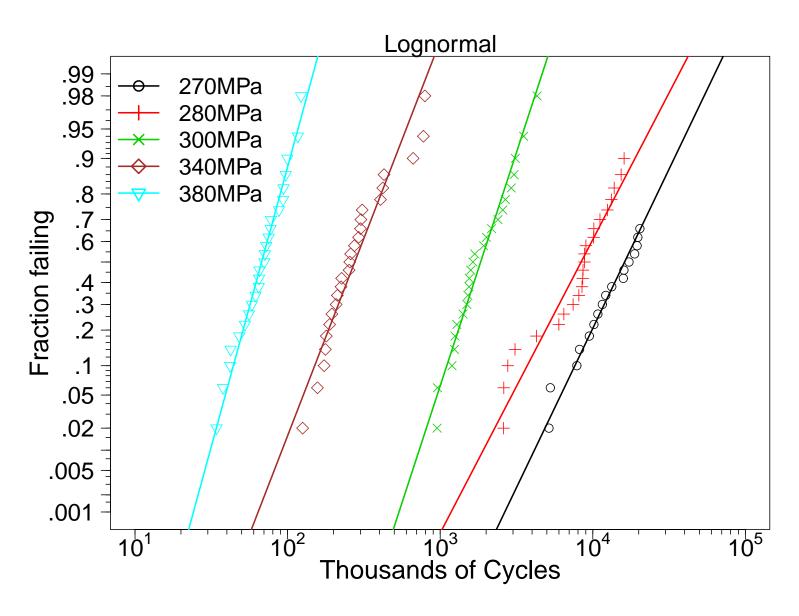
#### Laminate Panel Data Scatter Plot Log-Log Axes



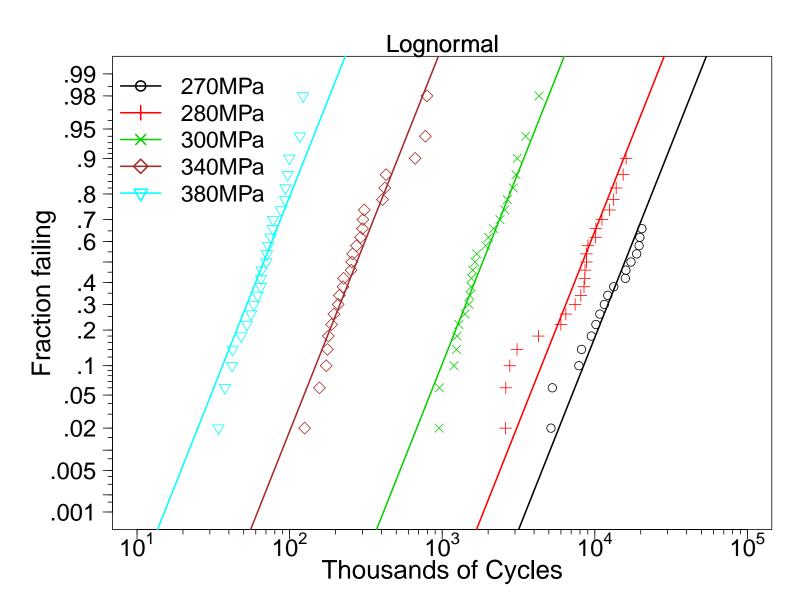
## Laminate Panel Data Multiple Weibull Probability Plot Different Shape Parameters



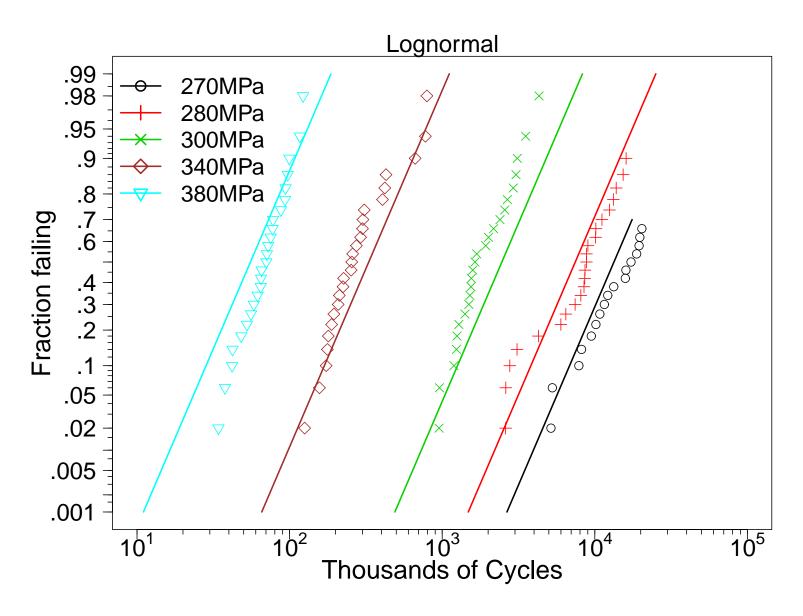
## Laminate Panel Data Multiple Lognormal Probability Plot Different Shape Parameters



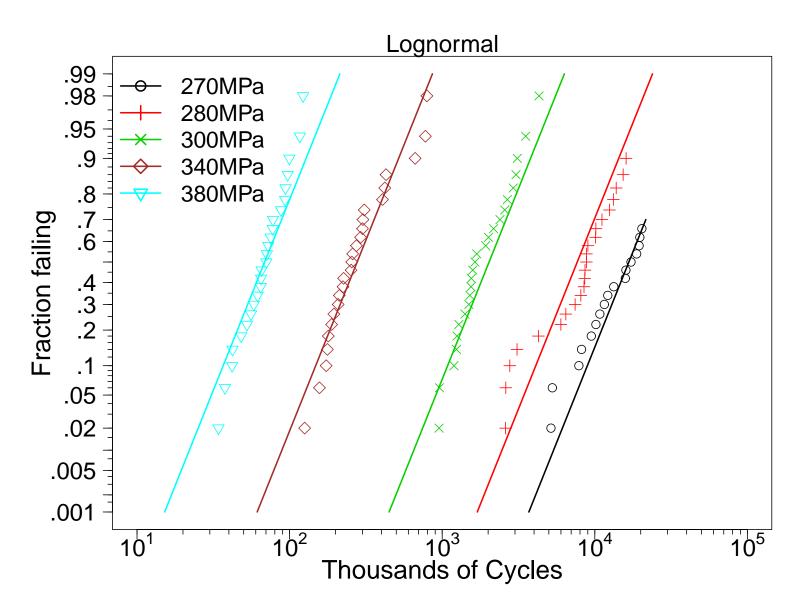
## Laminate Panel Data Multiple Lognormal Probability Plot Equal Shape Parameter



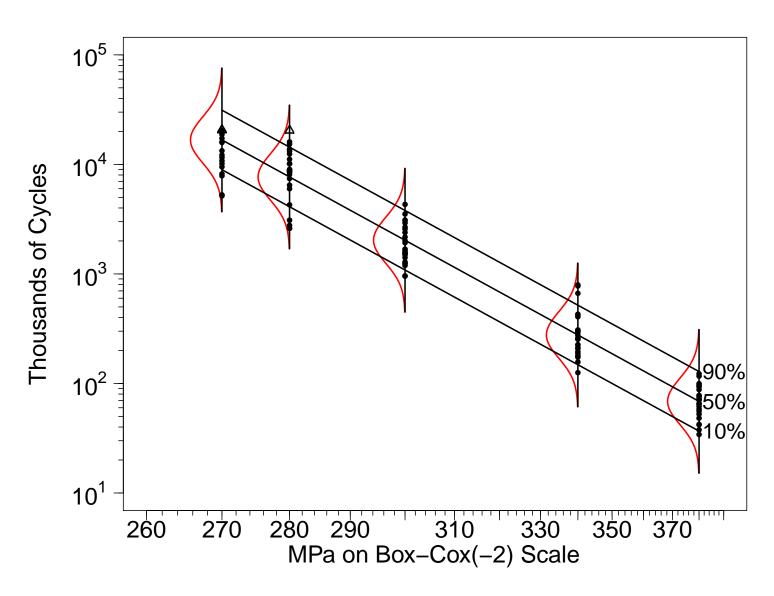
## Laminate Panel Data Multiple Lognormal Probability Plot Inverse Power Rule Model



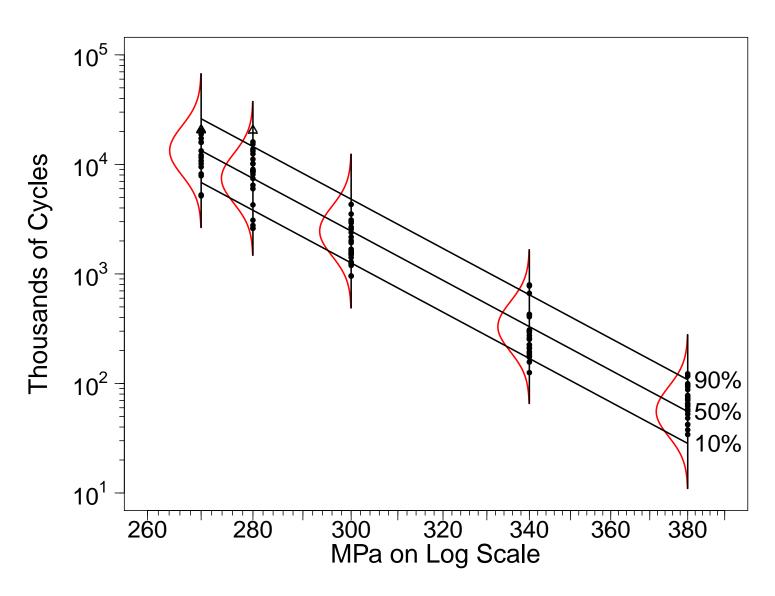
#### Laminate Panel Data Multiple Lognormal Probability Plot Box-Cox Power Law Model $\lambda=-2$



#### 



#### Laminate Panel Data Model Plot Log Transformation



Laminate Panel Data
Lognormal Model-Fitting Summary
Box-Cox Regression Model with Power -2

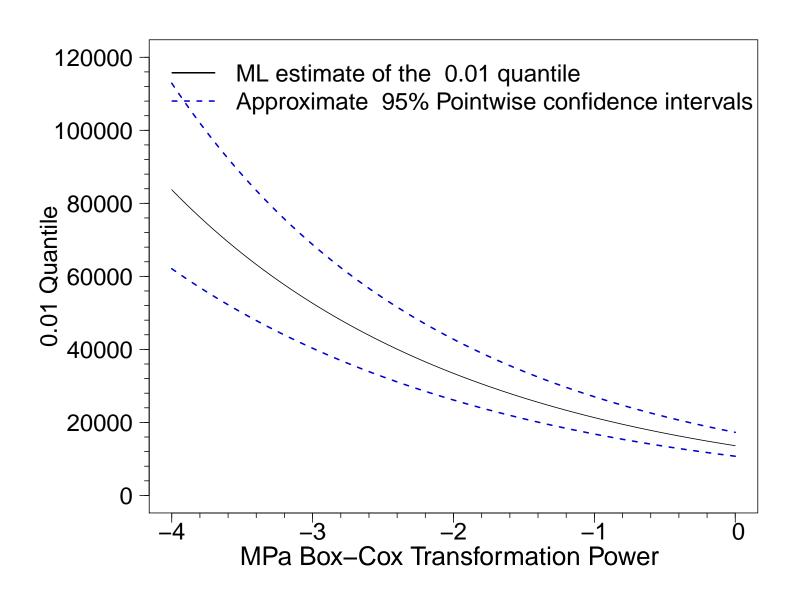
Model	-2LogLike	AIC	# Param
SepDists	1765	1785	10
EqualSig	1777	1789	6
RegrModel	1779	1785	3
Pooled	2130	2134	2

## Laminate Panel Data Lognormal Likelihood Ratio Tests

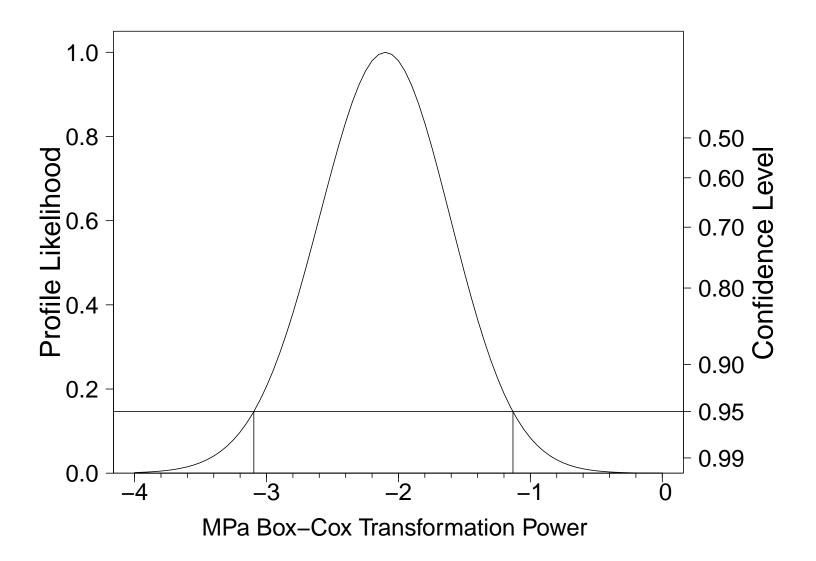
#### Box-Cox Regression Model with Power -2

Comparison	LR Statistic	dof	<i>p</i> -value
SepDists vs EqualSig	12.31	4	0.015
EqualSig vs RegrModel	1.54	3	0.67
RegrModel vs Pooled	351.31	1	< 0.001

### Laminate Panel Box-Cox Sensitivity Analysis at Stress Level 250 MPa



## Laminate Panel Box-Cox Sensitivity Analysis Profile Relative Likelihood



#### Chapter 17

Failure-Time Regression Analysis

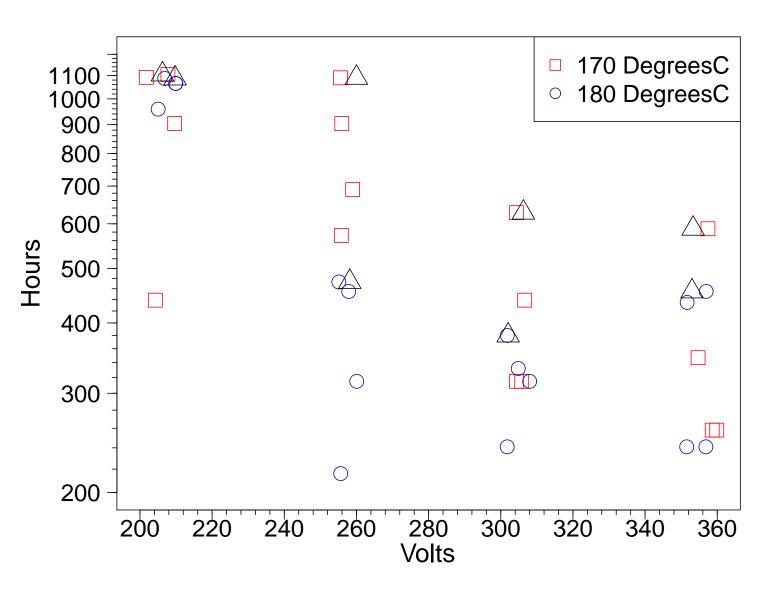
Segment 5

Failure-Time Regression Analysis with Two Explanatory Variables

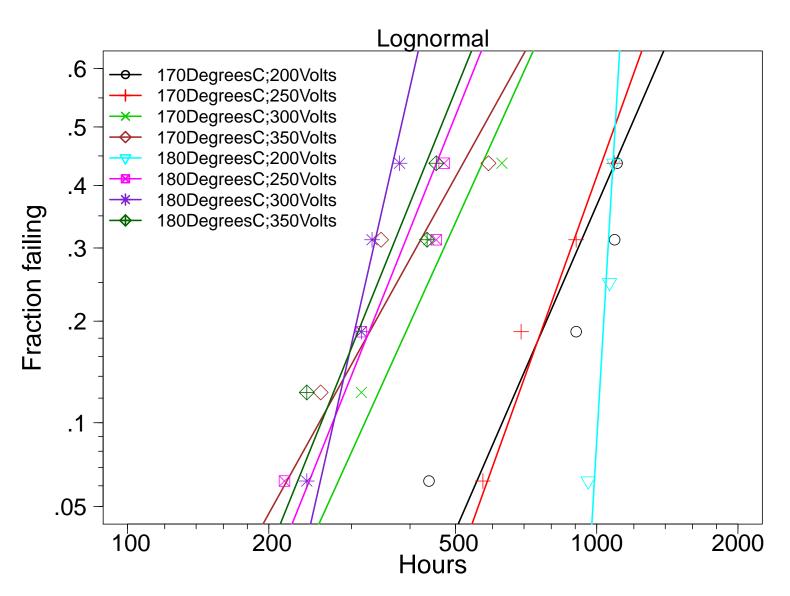
### Two or More Explanatory Variables: Glass Capacitor Failure Data

- Experiment designed to determine the effect of voltage and temperature on capacitor life.
- $\bullet$  2 × 4 factorial, 8 units at each combination.
- Test at each combination run until 4 of 8 units failed (Type 2 censoring).
- Original data from Zelen (1959).

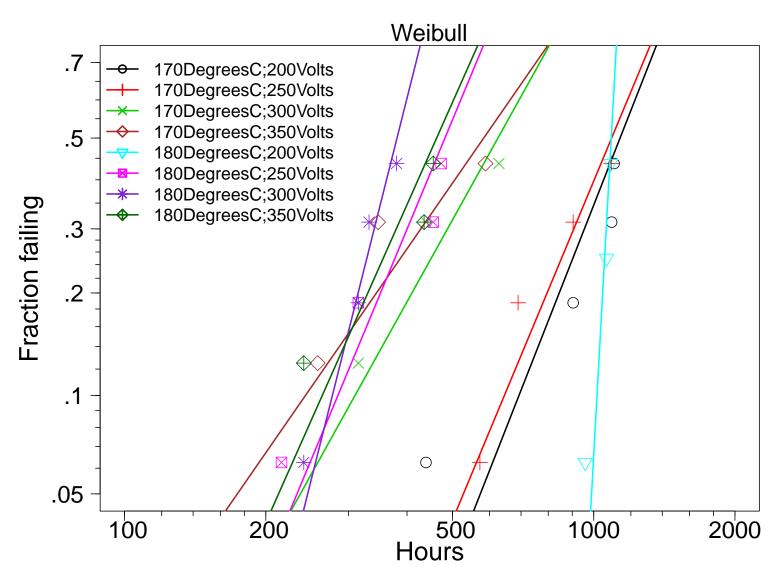
## Scatter Plot the Effect of Voltage and Temperature on Glass Capacitor Life



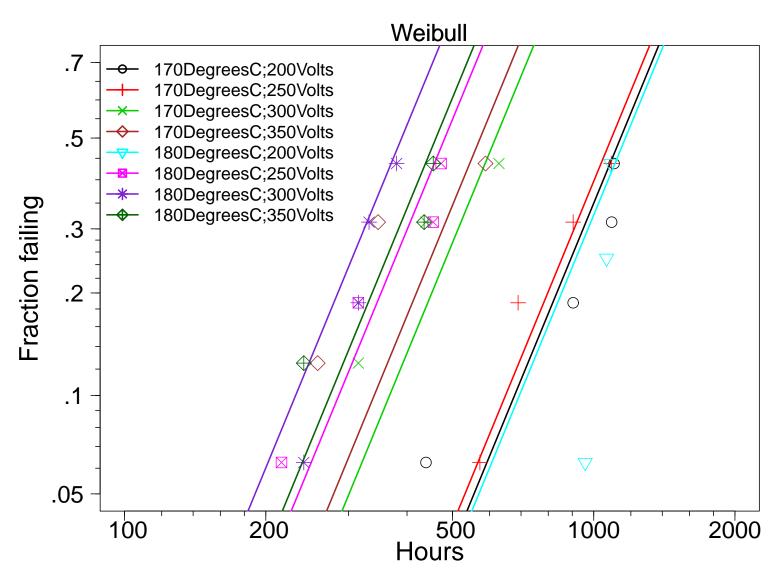
#### Lognormal Probability Plot Glass Capacitor Life Test Results Different Shape Parameters



#### Weibull Probability Plot Glass Capacitor Life Test Results Different Shape Parameters



#### Weibull Probability Plot Glass Capacitor Life Test Results Equal Shape Parameter



### Glass Capacitor Life Test Two-Variable Regression Models

The additive model is

$$\log[t_p(x)] = y_p(x) = \beta_0 + \beta_1 x_1 + \beta_2 x_2 + \Phi^{-1}(p)\sigma,$$
 where  $x_1$  = Temperature and  $x_2$  = Voltage.

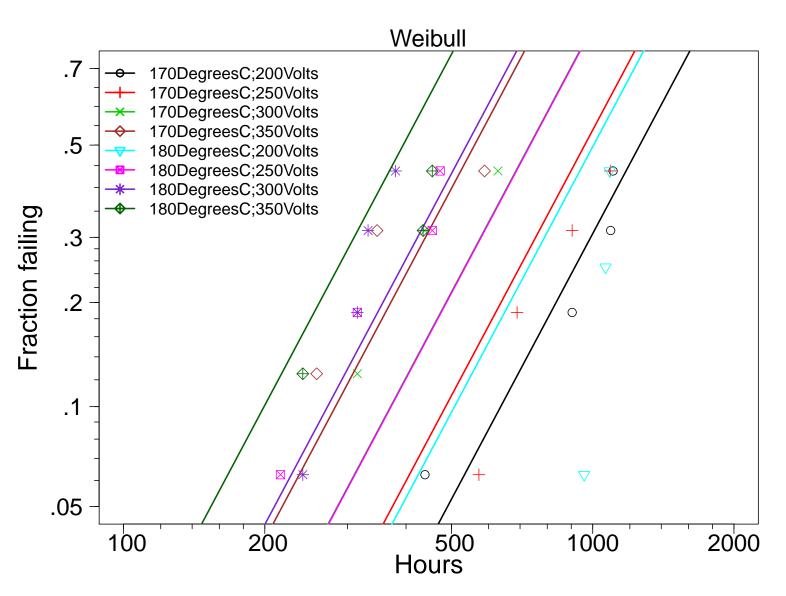
The interaction model is

$$\log[t_p(x)] = y_p(x) = \beta_0 + \beta_1 x_1 + \beta_2 x_2 + \beta_3 x_1 x_2 + \Phi^{-1}(p)\sigma.$$

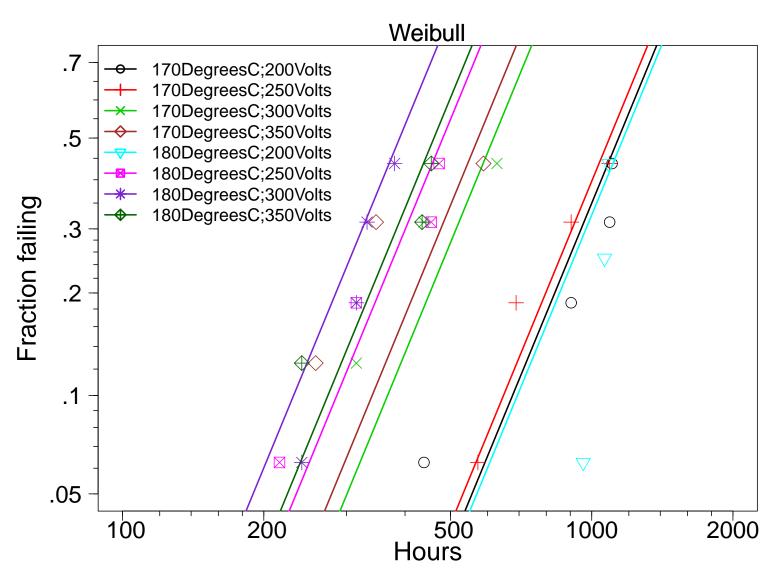
Comparing the two models gives

$$-2\times(\mathcal{L}_1-\mathcal{L}_2) = -2\times(-244.24 + 244.17) = 0.14$$
 which is small relative to  $\chi^2_{(0.95,1)} = 3.84$ .

## Weibull Probability Plot Glass Capacitor Life Test Results Interaction Model



#### Weibull Probability Plot Glass Capacitor Life Test Results Equal Shape Parameter



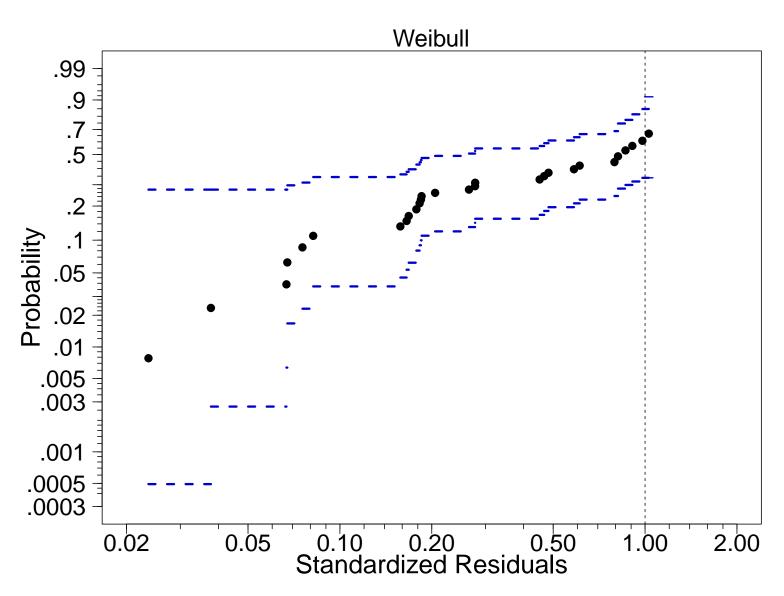
### Glass Capacitor Life Test Results Weibull Distribution-Fitting Summary

Model	-2LogLike	AIC	# Param
SepDists	463.3	495.3	16
EqualSig	476.3	494.3	9
RegrModel	488.5	496.5	4
Pooled	509.1	513.1	2

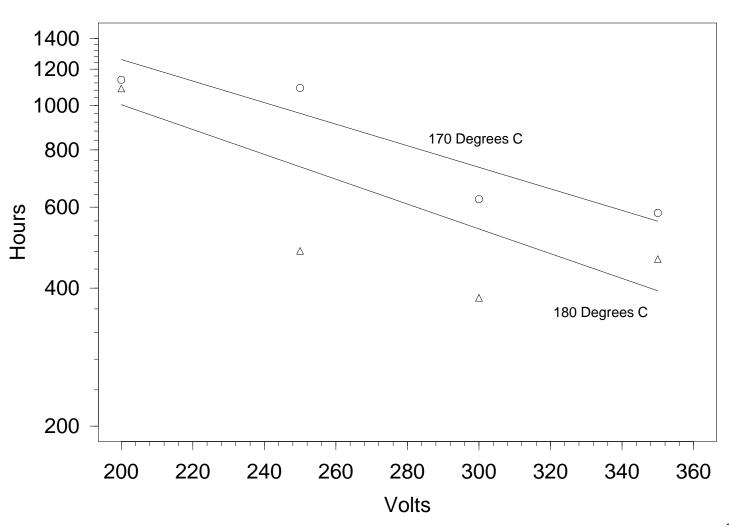
## Glass Capacitor Life Test Results Weibull Distribution-Fitting Summary

Comparison	LR Statistic	dof	<i>p</i> -value
SepDists vs EqualSig	12.96	7	0.073
EqualSig vs RegrModel	12.19	5	0.032
RegrModel vs Pooled	20.57	2	< 0.001

#### Weibull Probability Plot of the Interaction-Model Residuals Glass Capacitor Life Test Results



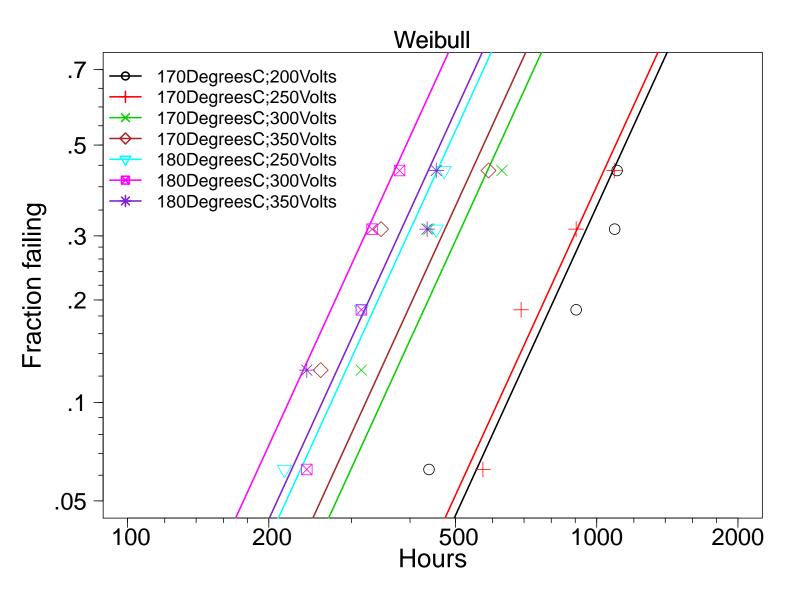
# Estimates of Weibull $t_{0.5}$ Plotted for each Combination of the Glass Capacitor Test Conditions Model with Interaction Points are Regression-Model-Free Estimates



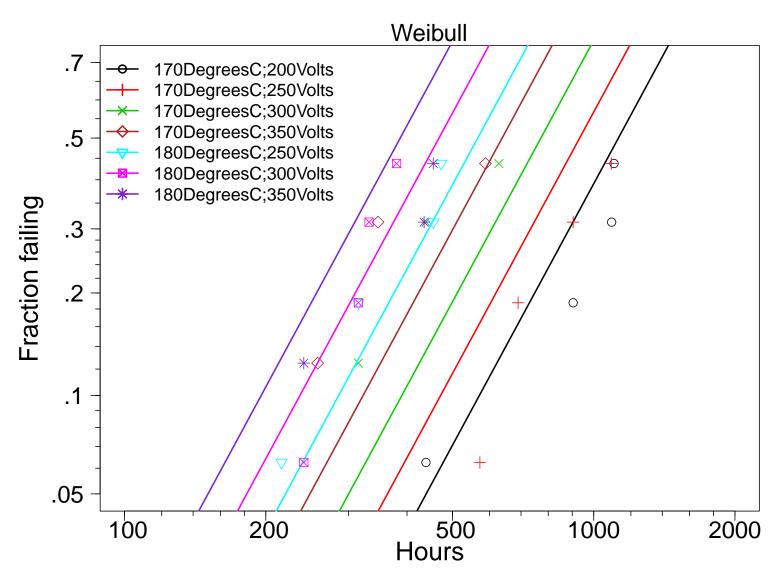
### Glass Capacitor Failure Data Analysis Excluding Data at 180°C and 200 Voltage

- Model fits indicate strong evidence of lack of fit due to data at 180°C and 200 Voltage.
- There is less spread in the data at that condition.
- Failure times at 180°C tend to be larger than those at 170°C. In particular, ML estimates suggest longer lifetime at the higher temperature.
- Refit the Weibull no-interaction regression with data at 180°C and 200 Voltage excluded.

## Weibull Probability Plot Glass Capacitor Subset Data Life Test Results Equal Shape Parameter



## Weibull Probability Plot Glass Capacitor Subset Data Life Test Results No-Interaction Model



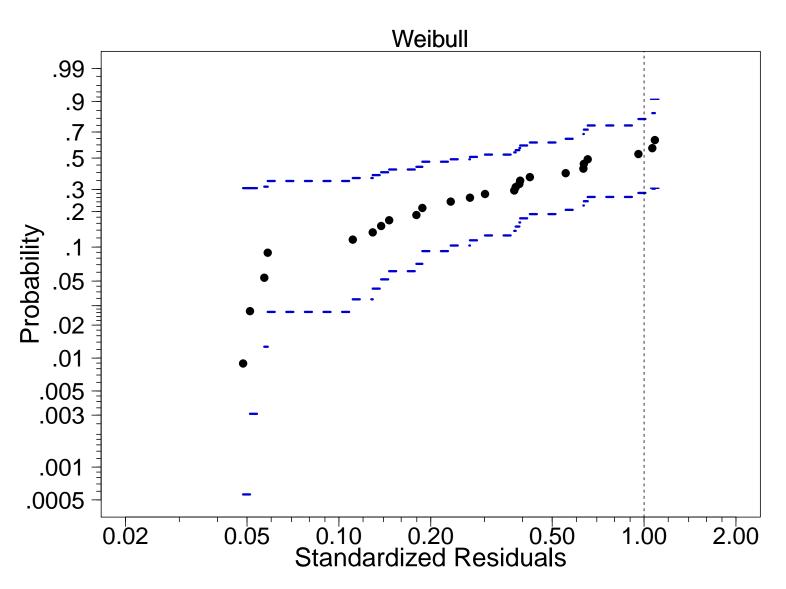
### Glass Capacitor Subset Data Life Test Results Weibull Distribution-Fitting Summary

Model	-2LogLike	AIC	# Param
SepDists	414	442	14
EqualSig	416	432	8
RegrModel	422	430	4
Pooled	441	445	2

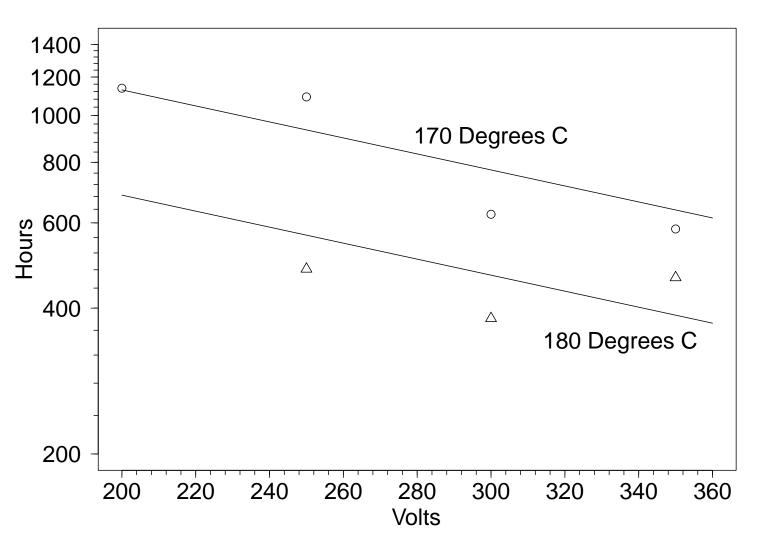
### Glass Capacitor Subset Data Life Test Results Weibull Distribution-Fitting Summary

Comparison	LR Statistic	dof	<i>p</i> -value
SepDists versus EqualSig	2.75	6	0.840
EqualSig versus RegrModel	5.96	4	0.201
RegrModel versus Pooled	18.30	2	< 0.001

#### Weibull Probability Plot of the No-Interaction Model Residuals Glass Capacitor Subset Data Life Test Results



# Estimates of Weibull $t_{0.5}$ Plotted for each Combination of the Glass Capacitor Subset Data Test Conditions Model with No Interaction Points are Regression-Model-Free Estimates



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